



IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Conformity Approved Process

IECQ Certificate No.: IECQ-P JQAJP 13.0006

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In respect of standards and specifications:

IEC 60747-10:1991

Semiconductor devices - Part 10: Generic specification for discrete
devices and integrated circuits

ISO 9001:2008

Quality management systems - Requirements

Component:

Semiconductor devices and Integrated circuits

Scope:

The purchase, manufacture and test of Semiconductor devices and
Integrated circuits.

This schedule is only valid in conjunction with the referenced Certificate of Approval

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